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October 2013

FGA60N65SMD 650 V, 60 A Field Stop IGBT

Features

- Maximum Junction Temperature: T_J = 175°C
- · Positive Temperature Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.9 V(Typ.)$ @ $I_C = 60 A$
- Fast Switching : E_{OFF} = 7.5 uJ/A
- · Tighten Parameter Distribution
- RoHS Compliant

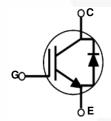
Applications

· Solar Inverter, UPS, Welder, PFC, Telecom, ESS

General Description

Using novel field stop IGBT technology, Fairchild's new series of field stop 2nd generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

Symbol	Description		Ratings	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		± 20	V
V GES	Transient Gate to Emitter Voltage		± 30	V
I _C	Collector Current	@ T _C = 25°C	120	Α
·C	Collector Current	$@T_{C} = 100^{\circ}C$	60	А
I _{CM (1)}	Pulsed Collector Current	180	Α	
I _F	Diode Forward Current	$@ T_C = 25^{\circ}C$	60	Α
	Diode Forward Current	$@T_C = 100^{\circ}C$	30	Α
I _{FM (1)}	Pulsed Diode Maximum Forward Currer	180	Α	
P _D	Maximum Power Dissipation	$@ T_C = 25^{\circ}C$	600	W
י ט	Maximum Power Dissipation	$@T_C = 100^{\circ}C$	300	W
T _J	Operating Junction Temperature	-55 to +175	°C	
T _{stg}	Storage Temperature Range		-55 to +175	°C
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds	300	°C	

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	-	0.25	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	-	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	40	°C/W

Package Marking and Ordering Information

Device Marking Device		Package	Reel Size	Tape Width	Quantity
FGA60N65SMD	FGA60N65SMD	TO-3PN	-	-	30

Electrical Characteristics of the IGBT T_C = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250\mu A$	650	-	-	٧
$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250\mu A$	-	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$	-	-	250	μΑ
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$	-	-	±400	nA
On Charac	teristics					
V _{GE(th)}	G-E Threshold Voltage	$I_{C} = 250 \mu A, V_{CE} = V_{GE}$	3.5	4.5	6.0	٧
(*)		I _C = 60A, V _{GE} = 15V	-	1.9	2.5	٧
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 60A, V _{GE} = 15V, T _C = 175°C	-	2.1	-	V
Dynamic C	haracteristics					
C _{ies}	Input Capacitance		-	2915	-	pF
C _{oes}	Output Capacitance	$V_{CE} = 30V_{,} V_{GE} = 0V_{,}$ f = 1MHz	-	270	-	pF
C _{res}	Reverse Transfer Capacitance	11 - 1101112	-	85	-	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time		-/	18	27	ns
t _r	Rise Time		-	47	70	ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 400V, I_{C} = 60A,$	-	104	146	ns
t _f	Fall Time	$R_G = 3\Omega, V_{GE} = 15V,$	-	50	68	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C	-	1.54	2.31	mJ
E _{off}	Turn-Off Switching Loss		-	0.45	0.60	mJ
E _{ts}	Total Switching Loss		-	1.99	2.91	mJ
t _{d(on)}	Turn-On Delay Time		-	18	-	ns
t _r	Rise Time	$V_{CC} = 400V, I_{C} = 60A,$ $R_{G} = 3\Omega, V_{GE} = 15V,$	-	41	-	ns
t _{d(off)}	Turn-Off Delay Time		-	115	-	ns
t _f	Fall Time		-	48	-	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 175°C	-	2.08	-	mJ
E _{off}	Turn-Off Switching Loss		-	0.78	-	mJ
E _{ts}	Total Switching Loss		-	2.86	-	mJ

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
Qg	Total Gate Charge		-	189	284	nC
Q _{ge}	Gate to Emitter Charge	$V_{CE} = 400V, I_{C} = 60A,$ $V_{GE} = 15V$	-	20	30	nC
Q _{gc}	Gate to Collector Charge	VGE - 10V	-	91	137	nC

Electrical Characteristics of the Diode $T_C = 25$ $^{\circ}$ C unless otherwise noted

Symbol	Parameter	Test Condi	Test Conditions		Тур.	Max	Unit
V _{FM} Diode Fo	Diode Forward Voltage	orward Voltage I _F = 30A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	2.1	2.6	V
	Diode Formara Voltage		$T_{\rm C} = 175^{\rm o}{\rm C}$	-	1.7	-	
E _{rec}	Reverse Recovery Energy		$T_{\rm C} = 175^{\rm o}{\rm C}$	-	127	-	uJ
t.		I _F =30A, dI _F /dt = 200A/μs	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	47	-	ns
^L rr			$T_{\rm C} = 175^{\rm o}{\rm C}$	-	212	-	110
Q _{rr} Diode Reverse Recovery Charge	Diode Beverse Becovery Charge		$T_C = 25^{\circ}C$	-	87	-	nC
	2.500 Hovered Hoselvery Ghange		$T_{\rm C} = 175^{\rm o}{\rm C}$	-	933	-]

Figure 1. Typical Output Characteristics

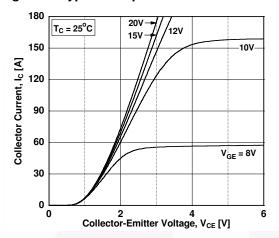


Figure 3. Typical Saturation Voltage Characteristics

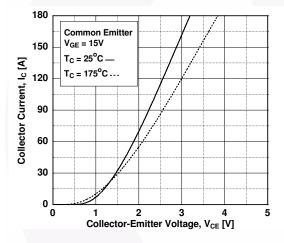


Figure 5. Saturation Voltage vs. V_{GE}

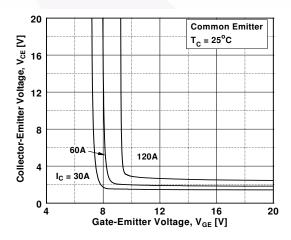


Figure 2. Typical Output Characteristics

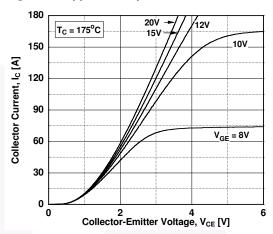


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

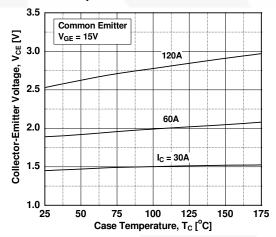


Figure 6. Saturation Voltage vs. V_{GE}

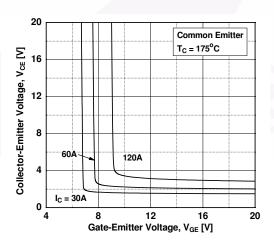


Figure 7. Capacitance Characteristics

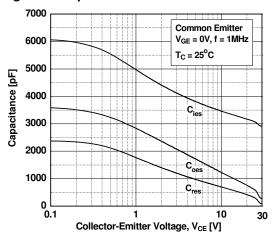


Figure 9. Turn-on Characteristics vs.
Gate Resistance

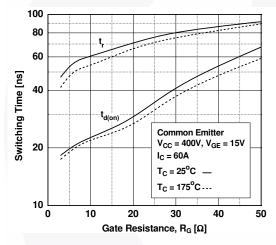


Figure 11. Switching Loss vs.
Gate Resistance

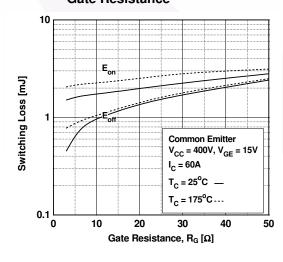


Figure 8. Gate charge Characteristics

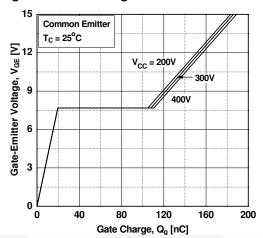


Figure 9. Turn-off Characteristics vs.
Gate Resistance

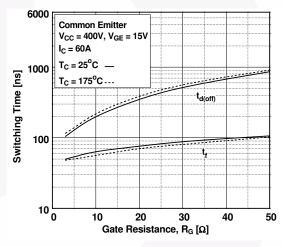


Figure 12. Turn-on Characteristics vs. Collector Current

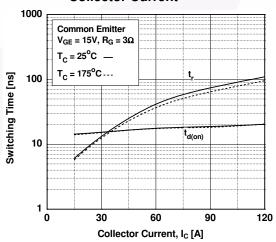


Figure 13. Turn-off Characteristics vs. Collector Current

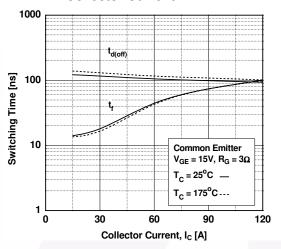


Figure 15. Load Current Vs. Frequency

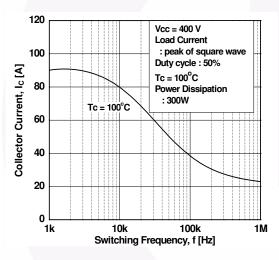


Figure 17. Forward Characteristics

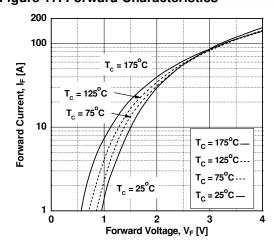


Figure 14. Switching Loss vs.. Collector Current

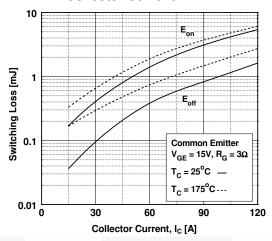


Figure 16. SOA Characteristics

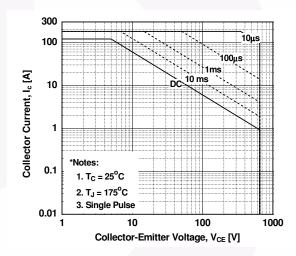


Figure 18. Reverse Recovery Current

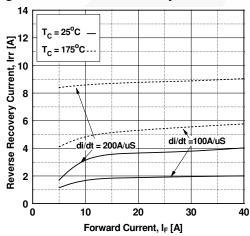


Figure 19. Reverse Recovery Time

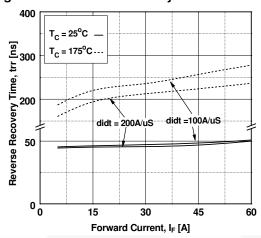


Figure 20. Stored Charge

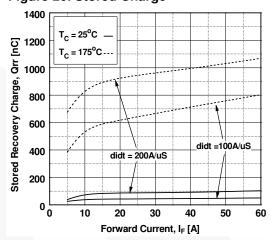


Figure 21. Transient Thermal Impedance of IGBT

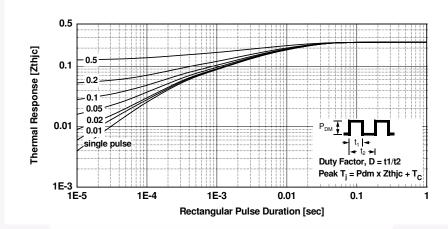
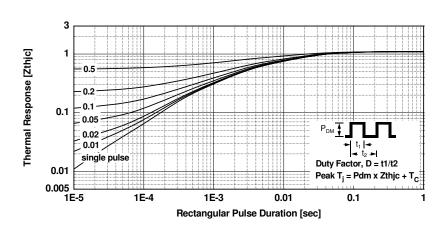


Figure 22. Transient Thermal Impedance of Diode



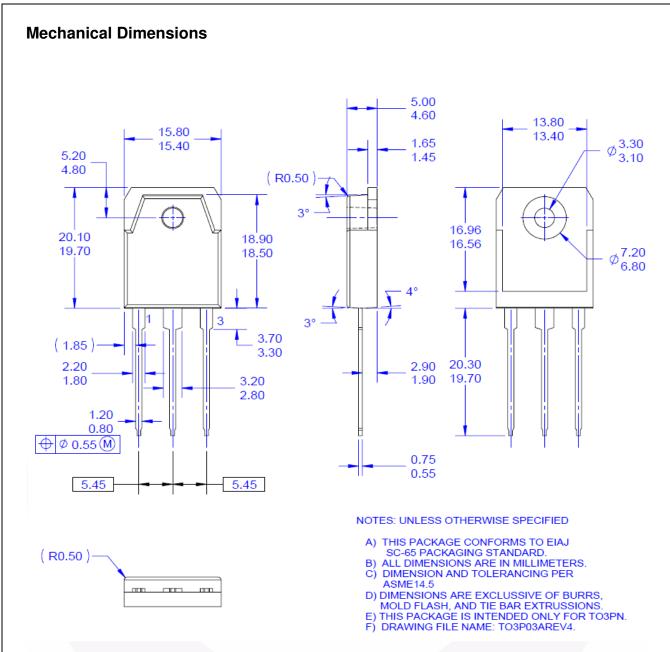


Figure 20. TO-3P 3L - 3LD, T03, PLASTIC, EIAJ SC-65

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Dimensions in Millimeters





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